



दिनांक/Date	अगले अंशांकन हेतु अनुशंसित तिथि Recommended date for the next calibration	पृष्ठ/Page	पृष्ठों की संख्या/No of pages
12 07 2023	12 07 2024	1	4

- Calibrated for : Biomedical Metrology Section National Physical Laboratory, New Delhi, 110012
Customer Ref. No. Nil
Date: 10-07-2023
- Description and Identification of Item under Calibration : Defibrillator Analyser
Model No.: 7000DP, Sr. No.: 3819017
Make: Fluke Biomedical
- Environmental Conditions : Temperature: (25 ±2) °C
Relative Humidity: (50 ±10) %
- Standard(s) used (with Associated uncertainty) : 1. Digital Storage Oscilloscope (Model No.: TBS 2072; Sr. No.: C020293; Make: Tektronix);
(-182.8 to -582.4) mV ±1.5 mV (k=2.32) ;
(215.8 to 2207) mV ±(1.5 to 2.0) mV (k=2.02 to 2.32);
Time (sec): (19.994 ±1 x 10⁻³) µs (k=2)
2. High Voltage Divider (Model No.: VD 15-8.3-A-LB-AL;
Sr. No.: 170313, Make: Ross Engg. Corp.),
(1000:1) 0.9975 ±0.1 % (k=2.1)
3. Digital Multimeter (Model No. 8846A; Sr.No.: 3641001; Make: Fluke);
(19.0009 ±0.0003) Ω (k=2)
4. Defibrillator (Model No.: TEC5621; S. No.: 01273; Make: Nihon Kohden);
(9.5 ±0.1) J (k=2.16)
(19.3 ±0.1) J (k=2.00)
(48.2 ±0.2) J (k=2.13)
(97.1 ±0.3) J (k=2.00)
(146.1 ±0.5) J (k=2.06)
(259.5 ±0.8) J (k=2.05)
- Traceability of standard(s) used : The standards used for calibration are traceable to National Standards, which realize the units of quantities according to the International System of Units (SI)
- Principle /Methodology of calibration and Calibration Procedure number : Calibration procedure as specified in Sub-Div # 3.03/ Doc3/CP #2

आशंकितकर्ता

Calibrated by :

VINOD KUMAR TANWAR

जाँचकर्ता

Checked by :

VED VARUN AGRAWAL

प्रभारी वैज्ञानिक

Scientist-in-charge :

Dr. RAJESH

जारीकर्ता

Issued by :



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7. Result(s):

Table 1: This is Table 1

Sr. No.	Energy applied (J) to UUC	Calculated (J) level	Measured Energy (J) level of UUC	Energy correction (J) (Ecalculated-Emeasured)	Uncertainty (J)	Coverage Factor (k)
1	10	9.500000	9.600000	(-) 0.1	±0.1	2
2	20	19.300000	19.400000	(-) 0.1	±0.1	2
3	50	48.200000	48.400000	(-) 0.2	±0.2	2
4	100	97.100000	97.400000	(-) 0.3	±0.3	2
5	150	146.100000	146.400000	(-) 0.3	±0.5	2
6	270	259.500000	260.300000	(-) 0.8	±0.9	2

Table 2: This is Table 2

Sr. No.	Discharge Time	Calculated Discharge Time (ms)	Measured Discharge Time (ms)	Uncertainty (J)	Coverage Factor (k)
1	Discharge Time (Positive Pulse Width)	6.600000	6.400000	±0.1	2.170000
2	Discharge Time (Negative Pulse Width)	4.400000	4.500000	±0.1	2.000000

Table 3: This is Table 3

Sr. No.	Defibrillator Analyser Load Resistance (Ω)	Expected Value (Ω)	Measured Value (Ω)	Uncertainty (Ω)	Coverage Factor (k)
1	50	50	50.017900	±0.00041	2.050000

Table 4: This is Table 4

Sr. No.	Defibrillator Analyser Load Resistance (Ω)	Expected Value (Ω)	Measured Value (Ω)	Uncertainty (Ω)	Coverage Factor (k)
1	50	50	51.012800	±0.0005	2.110000

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सी एस आई आर- राष्ट्रीय भौतिक प्रयोगशाला
CSIR-NATIONAL PHYSICAL LABORATORY
 (वैज्ञानिक और औद्योगिक अनुसंधान परिषद)
 (Council of Scientific and Industrial Research)
 (राष्ट्रीय मापिकी विज्ञान संस्थान (एनएमआई), सदस्य बीआईपीएम एवं हस्ताक्षरकर्ता सीआईपीएम --एमआरए)
 (National Metrology Institute (NMI), Member BIPM and Signatory CIPM - MRA)
 डॉ के एस कृष्णन मार्ग, नई दिल्ली-110012, भारत
 Dr. K. S. Krishnan Marg, New Delhi-110012, INDIA
 दूरभाष/Phone : 91-11-4560 8441, 8589, 8610, 9447, फैक्स/Fax : 91-11-4560 8448
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अंशांकन प्रमाण पत्र
CALLIBRATION CERTIFICATE:
 Defibrillator Analyser

प्रमाण पत्र संख्या/Certificate number:
 N23070405/D3.03/C-037

डी ओ आई संख्या/DOI number :

X

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The expanded uncertainty in wavelength measurement at NPL. is ± 0.5 m.

The reported uncertainty is at Coverage factor 1-2, which corresponds to a coverage probability of approximately 95% for a normal distribution

8. Date(s) for calibration: 12.07.2023

9. Remark(s):
 (i) The measured values of peak wavelength are representation of the nearest reference Standard spectral lines as shown by the Spectrometer at the interval of each 0.1 mm.
 (ii) NPL identification No. of the Spectrometer for wavelength measurement is 402/0PT/202



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प्रभारी वैज्ञानिक
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नोट

1. यह प्रमाण पत्र सी एस आई आर-राष्ट्रीय भौतिक प्रयोगशाला, भारत जारी किया गया है जौ कि विज्ञान एवं प्रौद्योगिकी मंत्रालय, भारत सरकार के अधीन वैज्ञानिक व औद्योगिक अनुसंधान परिषद् की संघटक इकाई है एवम् भारत का राष्ट्रीय मापिकी संस्थान(NMI) भी है ।
2. यह प्रमाण पत्र केवल अंशांकन हेतु जमा किए गए मापिकी हेतु संदर्भित है।
3. इस प्रमाण पत्र की प्रतिलिपी, पूर्ण प्रमाण पत्र के अतिरिक्त, तैयार नहीं की जा सकती है, जब तक कि निदेशक, सी एस आई आर-राष्ट्रीय भौतिक प्रयोगशाला, नई दिल्ली से अनुमोदित सार के प्रकाशन हेतु लिखित अनुमति प्राप्त नहीं की गयी हो।
4. उस प्रमाण पत्र में प्रतिवेदित परीक्षण परिणाम केवल मापन की वर्णित परिस्थलियाँ एवं समय हेतु मान्य है।



NOTE

1. This certificate is issued by CSIR-National Physical Laboratory of India (NPLI) which is a constituent unit of the Council of Scientific & Industrial Research, the Ministry of Science and Technology, Government of India and is also National Metrology Institute (NMI) of India.
2. This certificate refers only to the particular item (s) submitted for calibration.
3. This certificate shall not be reproduced, except in full, unless written permission for the publication of an approved abstract has been obtained from the Director, CSIR- National Physical Laboratory. New Delhi.
4. The calibration results reported in this certificate are valid at the time and under the stated conditions of measurement.